



Safe Harbor Notice



This presentation may contain forward-looking statements. All statements, other than statements of historical facts, that address activities, events or developments that WinWay Technology Co., Ltd. expects or anticipates will or may occur in the future (including but not limited to projections, targets, estimates and business plans) are forward-looking statements.

WinWay's actual results or developments may differ materially from those indicated by these forward-looking statements as a result of various factors and uncertainties, including but not limited to market demand, price fluctuations, competition, change in legal, government policies, financial market conditions, and other risks and factors beyond our control.

This presentation does not undertake any obligation to publicly update any forward-looking statements to reflect events or circumstances after the date on which any such statement is made or to reflect the occurrence of unanticipated events.



Company Information

Founded

2001.4.10

Employees

1068

Chairman & CEO

Mark Wang

Capital Stock

NTD 360,491,820

Business Operation

Design, manufacture, sale and service of test interface products

Registered Address

No.68, Chuangyi S. Rd, Nanzi Dist. Kaohsiung City, Taiwan



USA Branch Office



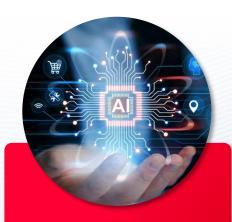
Kaohsiung Headquarter



Hsinchu Branch Office



Company Vision



Innovation

We deliver the best possible test tooling solutions to our customers through technological innovation.



Quality

We exceed customers'
quality requirements by
offering cost-effective total
solutions and on-time
delivery worldwide.



Service

We strive to become the world's leading professional testing service provider in all phases of IC testing.



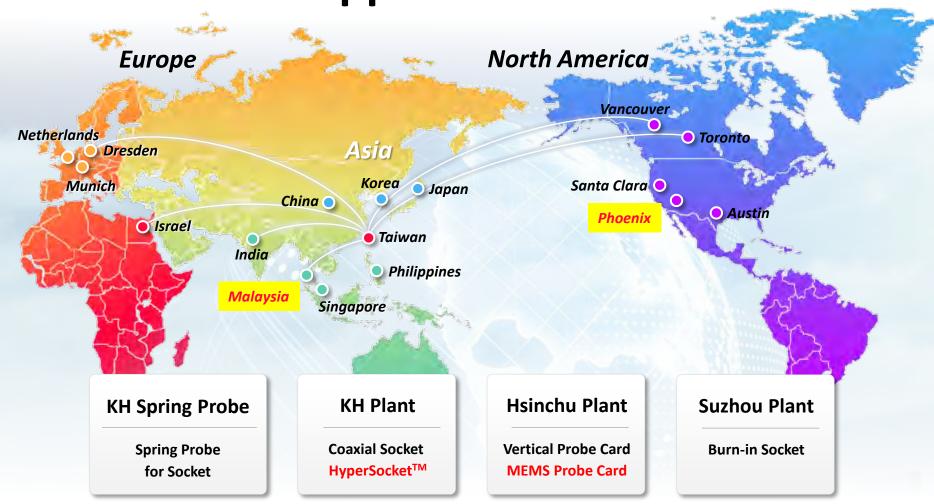
Agenda





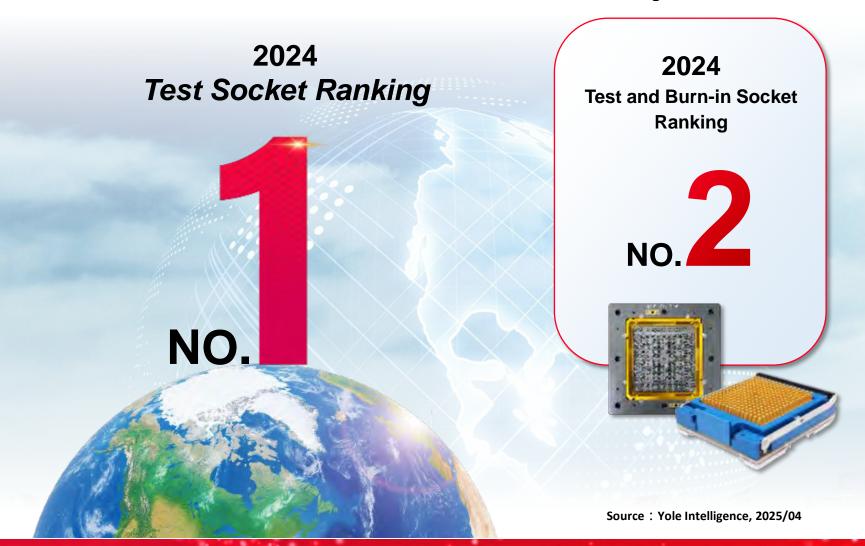


Global Service & Support Network





Semiconductor Test Interface Leadership



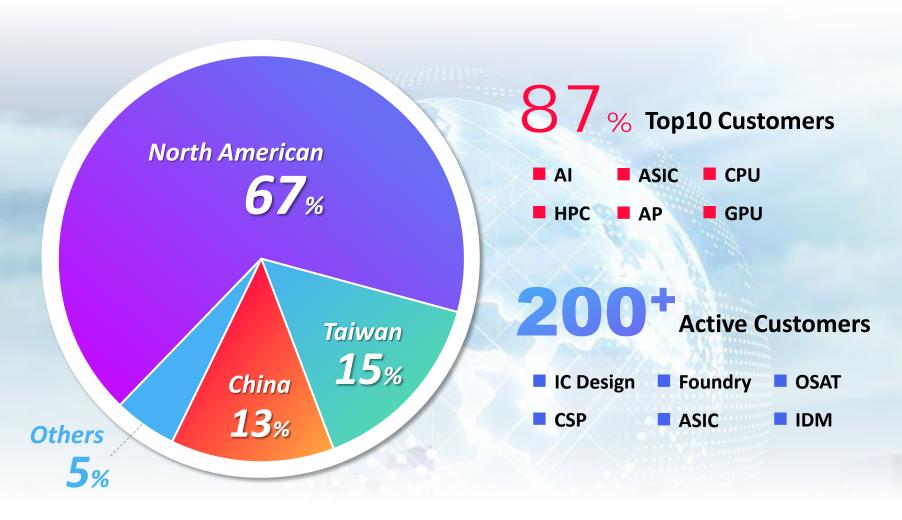


Your Trusted Partner in Semiconductor Testing



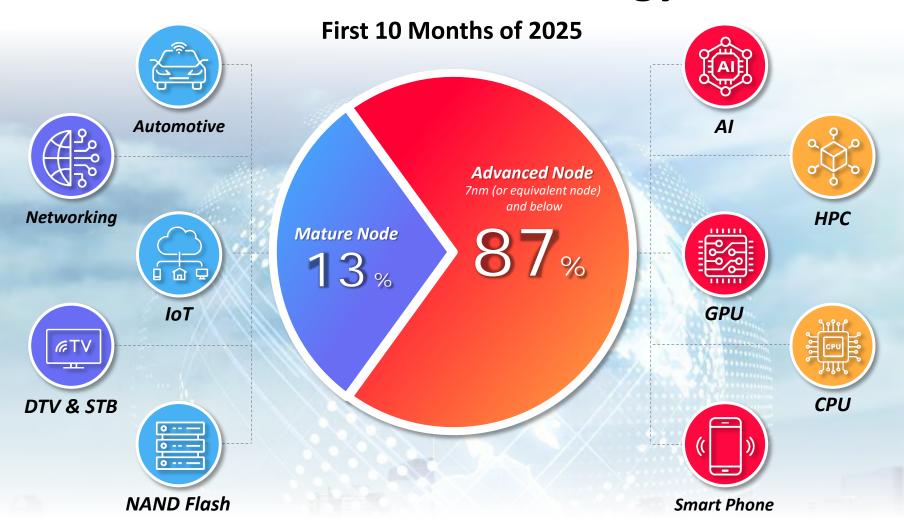


Worldwide Customer



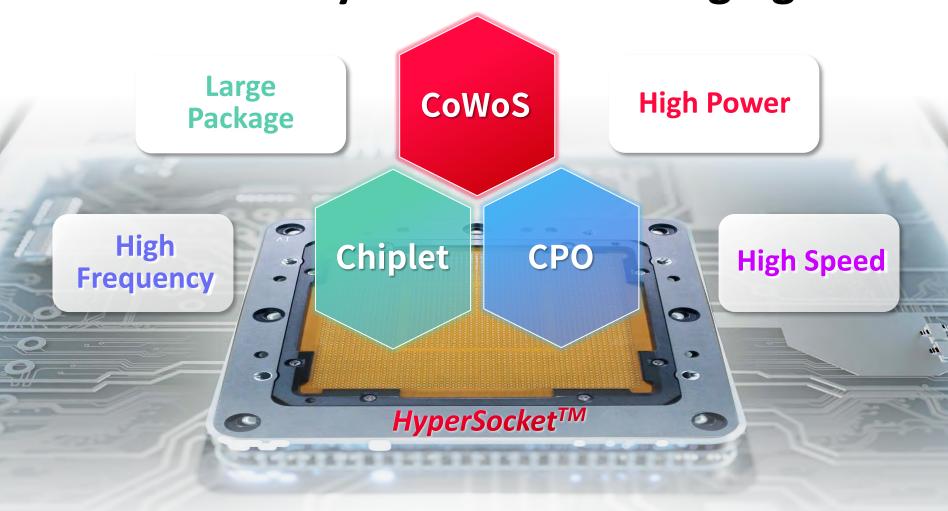


Bolstered by Advanced Technology





High Performance Testing Driven by Advanced Packaging







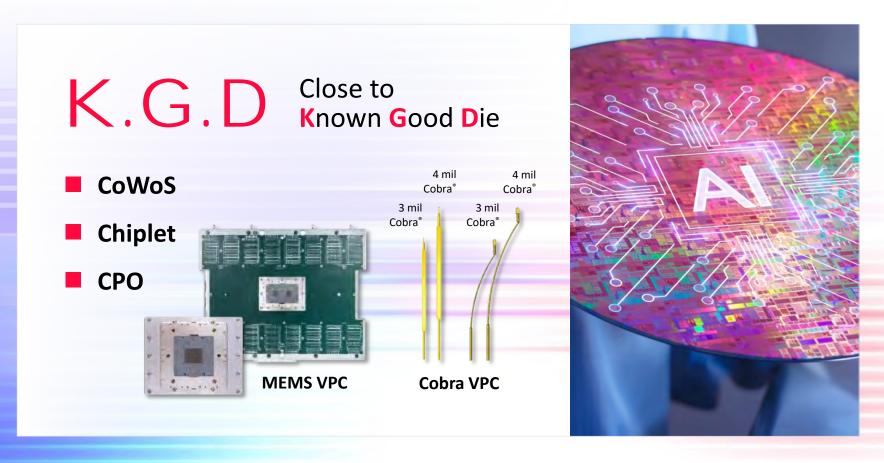
Driving Force for Al





Greater Importance on Chip Probing

From the Shadows to the Spotlight

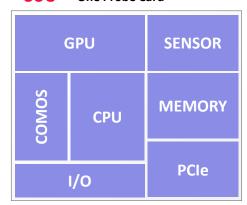




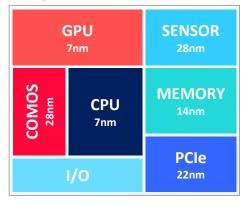
Known Good Die Is Required!

Probe Card Demand Induce

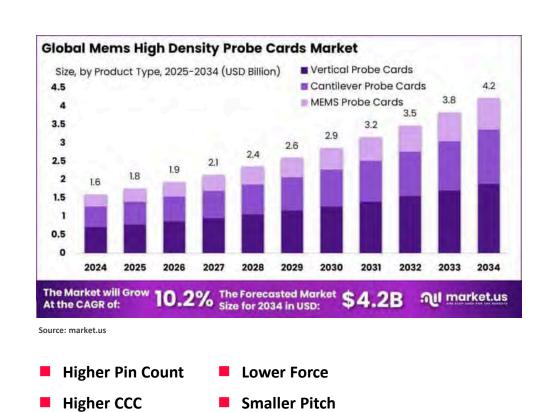
SoC One Probe Card







Source: Trend Force



Wider Operation Temperature

Higher Speed



Accelerated SLT Demand Driven by Al





Emerging Trend Toward Functional Burn-In

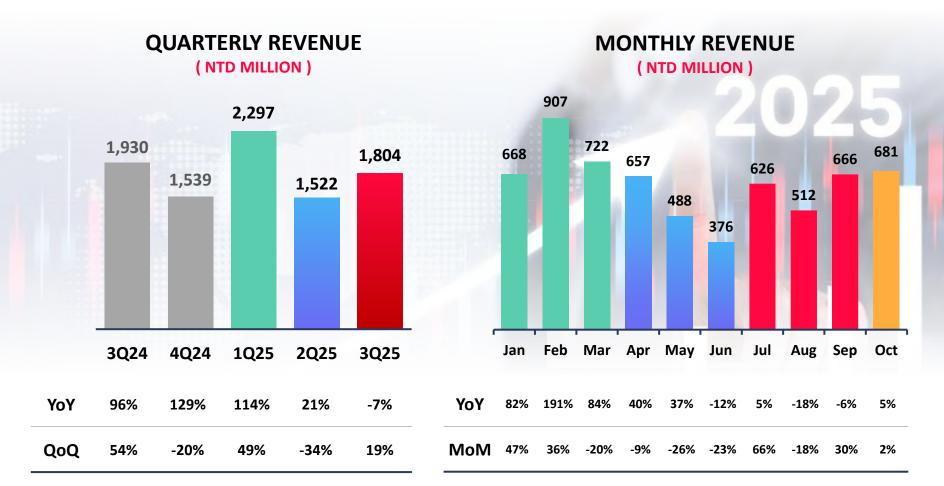






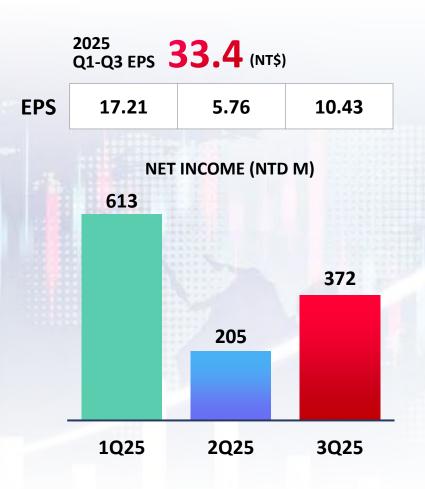


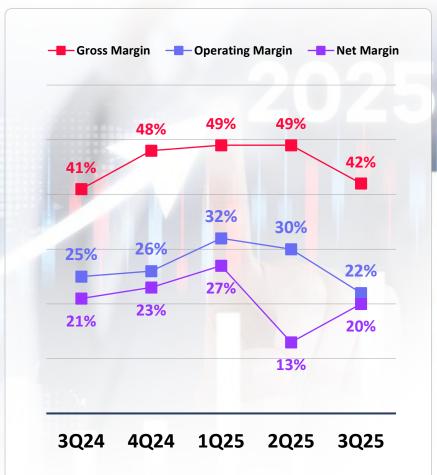
Revenue Trend





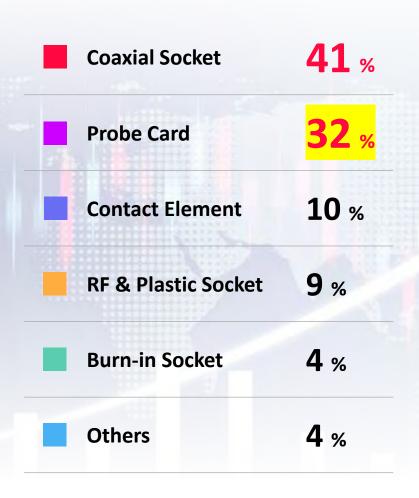
Profitability Trend

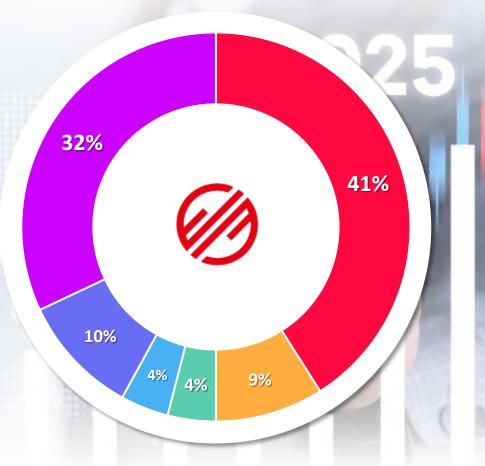






Revenue by Product Mix







Revenue by End Market



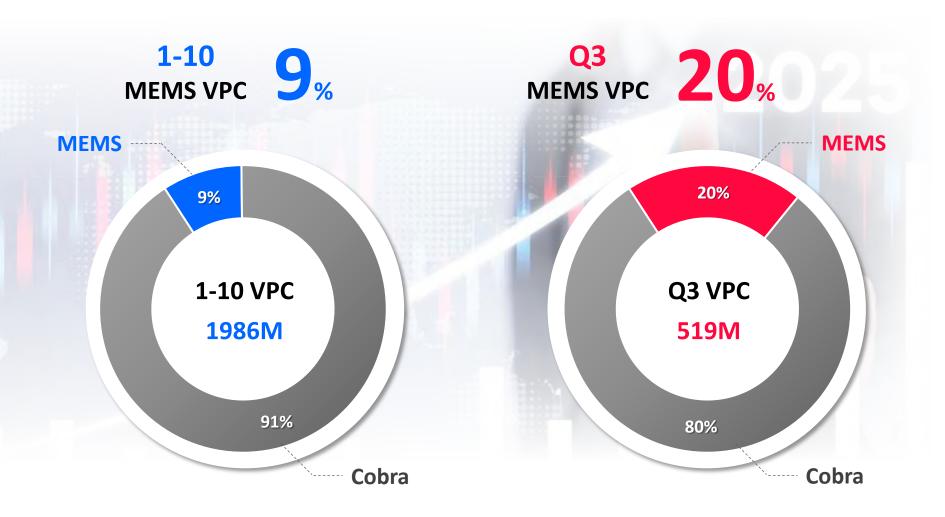








MEMS Probe Card





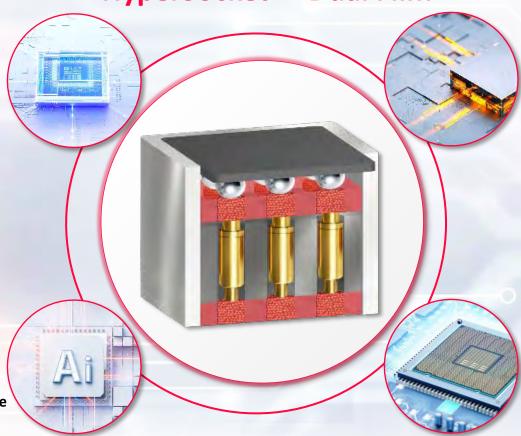


Innovative Semiconductor **Test Interface Solution**

HyperSocket[™]-Dual Film

Large Package

Larger contact area Improved heat dissipation **Enhanced test stability**



High Speed

Full metal shielding, short-loop design Test speed above 224Gbps

High Power

Various current pathways Mitigating temperature rise

High Pin Counts

Zero Pre-load design Reduced maintenance cost

Patent NO.

TWI862047

TWI884802

TWI862191

TWI901161

CN20570508U

Patent Pending

USA

Malaysia



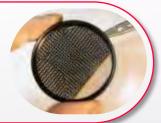
Innovative Semiconductor Test Interface Solution

Liquid Cooling Socket



Patent NO. TWI901181

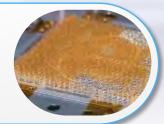
Extraordinary heat dissipation



Improved Test Stability for Advanced Packaging



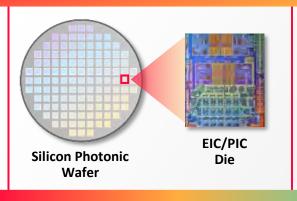
Extend Spring Probe Lifespan



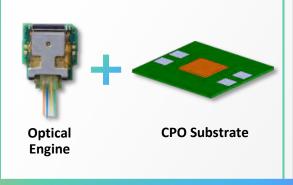


Co-Packaged Optics Test Solution





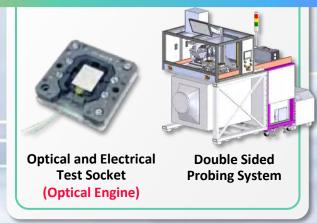




Module Level





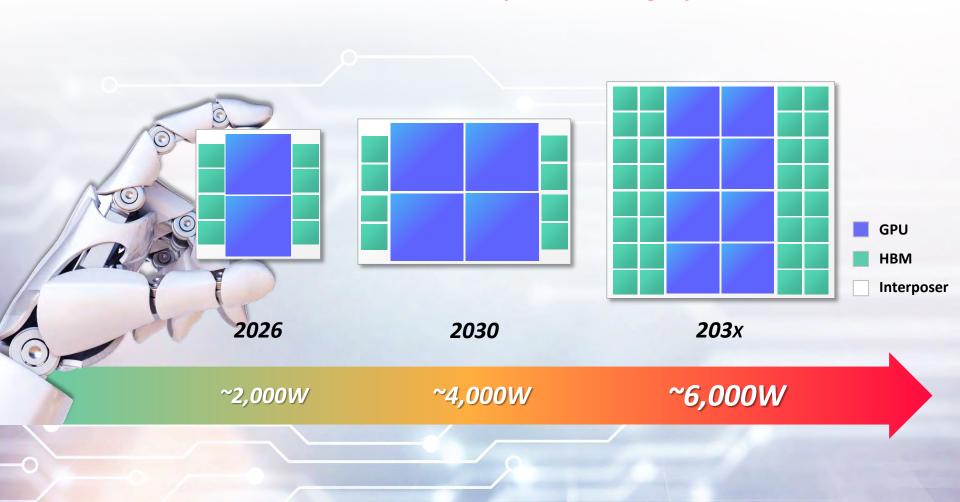






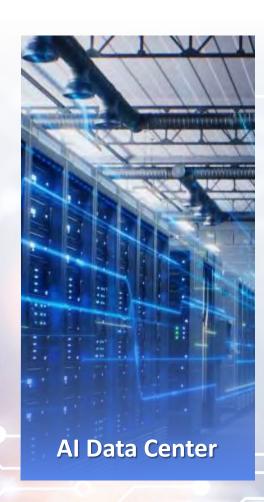
High Power Thermal Solution

E-Flux6.0 3500W Liquid Cooling System





AI Server Board-Level Test







Spring Probe Manufacturing

Socket All in House



Cost Optimization

Balanced insourcing, better cost structure

Self-Sufficiency

Autonomy of critical process technology

Quality Assurance

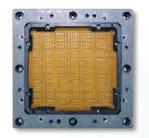
Greater customer experience

Operational Resilience

More flexible, agile lead time

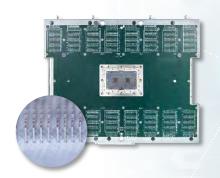


Pillars of Business Growth



HyperSocketTM

Positioned for advanced packaging



MEMS Probe Card

Localized service for AI/HPC



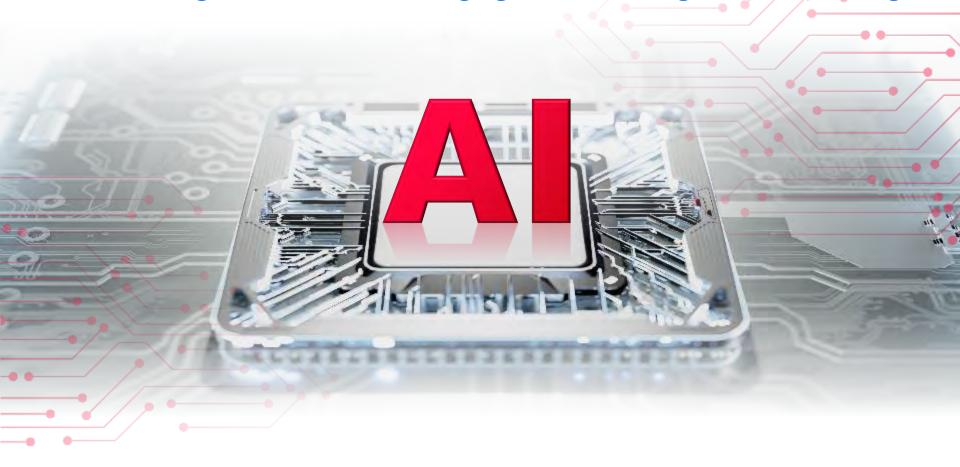
Functional Burn-in

Pioneer in emerging application



Challenges and Opportunities:

Breakthrough in Advanced Packaging and Mastering Future of Testing





Advanced Package Application and Market Trend

Data Center Al Chip & ASIC



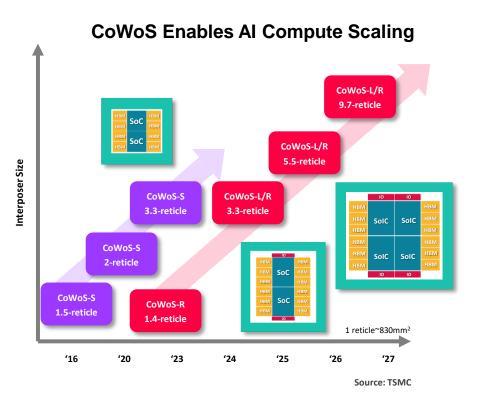
Datacenter GPU and AI ASIC revenue forecast



Source: Yole



Advanced Package Application and Market Trend



Global Advanced Semiconductor Packaging Market



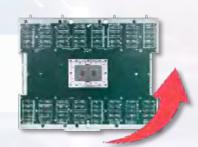
Source: market.us



Significant Increase in Testing Time

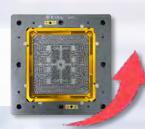
Longer Wafer Sort Test Time

MEMS and Cobra Probe card



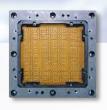
Longer FT (ATE) Test Time

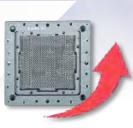
Plastic, Coaxial and HyperSocket™



Longer SLT Test Time

Coaxial and HyperSocket™







More Test Insertions

More Reliability Test Insertion

Functional Burn-In Socket



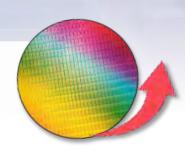
Bigger and Bigger Device Package
Higher and Higher Device Power Consumption

HyperSocket[™] and HyperSocket[™]-DF



Longer and Longer Fab In-process Time

Fab and OSAT expansion drive equipment demand





WinWay Industry Alliance and Integration **Across Heterogeneous Disciplines**

Alliance Heterogeneous Integration **ATE Tester** Artificial Intelligence **Thermal** Handler System CPU · GPU · HPC **Si Photonics Probe** Load **Board** Card Source: TSMC



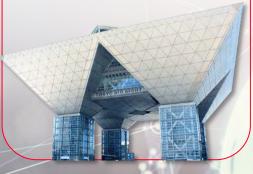
SEMICON JAPAN

2025.12.17—19



Japan

Tokyo Big Sight, Tokyo



SEMICON China

2026.03.25-27



China

Shanghai New International Expo Centre



SEMICON SEA

2026.05.05-07



Malaysia

Malaysia International Trade & Exhibition Centre







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THANKYOU

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